

<b>Notice of References Cited</b>	Application/Control No. 10/684,522	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Luz L. Alejandro	Art Unit 1763	Page 1 of 1

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*	B	US-2003/0111181	06-2003	Wang et al.	156/345.48
*	C	US-2004/0011467	01-2004	Hemker et al.	156/345.49
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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